# FDS7764A 30V N-Channel PowerTrench<sup>®</sup> MOSFET

## **General Description**

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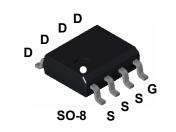
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for "low side" synchronous rectifier operation, providing an extremely low  $R_{DS(ON)}$  in a small package.

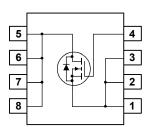
## **Applications**

- Synchronous Rectifier
- DC/DC converter

# Features

- 15 A, 30 V.  $R_{DS(ON)}$  = 7.5 m $\Omega$  @ V<sub>GS</sub> = 4.5 V
- High performance trench technology for extremely low R<sub>DS(ON)</sub> High power and current handling capability





# Absolute Maximum Ratings TA=25°C unless otherwise noted

Symbol		Parameter	Ratings	Units		
V <sub>DSS</sub>	Drain-Sour	ce Voltage		30	V	
V <sub>GSS</sub>	Gate-Source	e Voltage		±12	V	
ID	Drain Curre	ent – Continuous	(Note 1a)	15	A	
		<ul> <li>Pulsed</li> </ul>		50		
P <sub>D</sub>	Power Dissipation for Single Operation		ion (Note 1a)	2.5	W	
			(Note 1b)	1.2		
			(Note 1c)	1.0		
T <sub>J</sub> , T <sub>STG</sub>	Operating a	and Storage Junction Ter	-55 to +150	°C		
Therma R <sub>0JA</sub>	<b>I Charac</b>	teristics esistance, Junction-to-An	nbient (Note 1a)	50	°C/W	
R <sub>0JA</sub>	Thermal Resistance, Junction-to-Ambient (Note 1			50 (10 sec)	°C/W	
R <sub>eJC</sub>	Thermal Re	esistance, Junction-to-Ca	Se (Note 1)	30	°C/W	
Packag	e Markin	g and Ordering	Information		I	
Device Marking		Device	Reel Size	Tape width	Quantity	
FDS7764A		FDS7764A	13"	12mm	2500 units	

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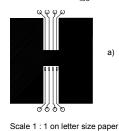
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics	I				
BV <sub>DSS</sub>	Drain–Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 µA, Referenced to 25°C		20		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V			1	μA
I <sub>GSSF</sub>	Gate-Body Leakage, Forward	V <sub>GS</sub> = 12 V, V <sub>DS</sub> = 0 V			100	nA
I <sub>GSSR</sub>	Gate–Body Leakage, Reverse	$V_{GS}$ = -12 V , $V_{DS}$ = 0 V			-100	nA
On Chara	acteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$	0.8	1.2	2.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	Threshold Voltage $I_D = 250 \mu$ A, Referenced to $25^{\circ}$ C		-4		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$V_{GS} = 4.5 V, I_D = 15 A$ $V_{GS} = 10 V, I_D = 15.5 A$ $V_{GS} = 4.5 V, I_D = 15 A, T_J = 125^{\circ}C$		6.0 5.3 9.0	7.5 13.0	mΩ
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS} = 4.5 V, V_{DS} = 5 V$	50			Α
<b>g</b> <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 15 A		75		S
Dynamic	Characteristics					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 15 V, V_{GS} = 0 V,$		5070		pF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz		550		pF
C <sub>rss</sub>	Reverse Transfer Capacitance	]		230		pF
Switchin	g Characteristics (Note 2)					
t <sub>d(on)</sub>	Turn–On Delay Time	$V_{DD} = 10 V, I_D = 1 A,$		17	25	ns
tr	Turn–On Rise Time	$V_{GS}$ = 4.5 V, $R_{GEN}$ = 6 $\Omega$		18	25	ns
$t_{d(off)}$	Turn–Off Delay Time			69	100	ns
t <sub>f</sub>	Turn–Off Fall Time			29	42	ns
Qg	Total Gate Charge	$V_{DS} = 15 V, I_{D} = 15 A,$		33	46	nC
Q <sub>gs</sub>	Gate–Source Charge	V <sub>GS</sub> = 4.5 V		7.5		nC
$Q_{gd}$	Gate–Drain Charge			6.8		nC
Drain-So	ource Diode Characteristics	and Maximum Ratings				
ls	Maximum Continuous Drain-Source			2.1	Α	
V <sub>SD</sub>	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$ , $I_S = 2.1 A$ (Note 2)		0.7	1.2	V

Notes:

1. R<sub>0JA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $\rm R_{_{\theta JC}}$  is guaranteed by design while  $\rm R_{_{\theta CA}}$  is determined by the user's board design.

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a) 50°/W when mounted on a 1in<sup>2</sup> pad of 2 oz copper

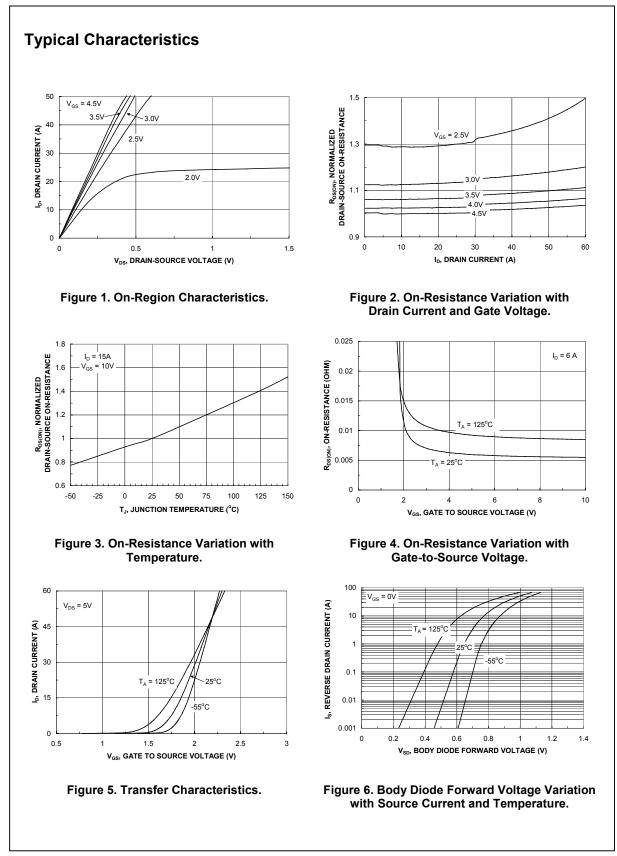
2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

b) 105°/W when mounted on a .04 in<sup>2</sup> pad of 2 oz copper 0000

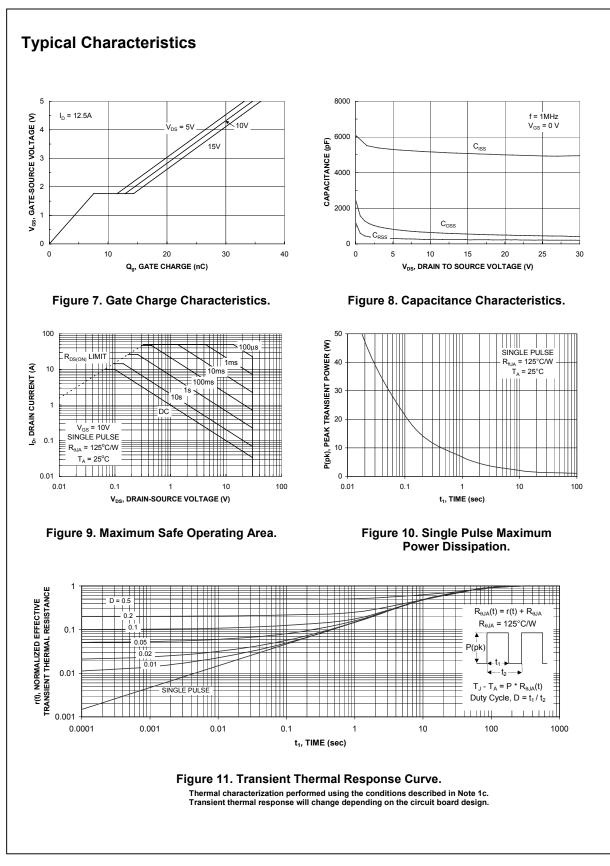
c) 125°/W when mounted on a minimum pad.

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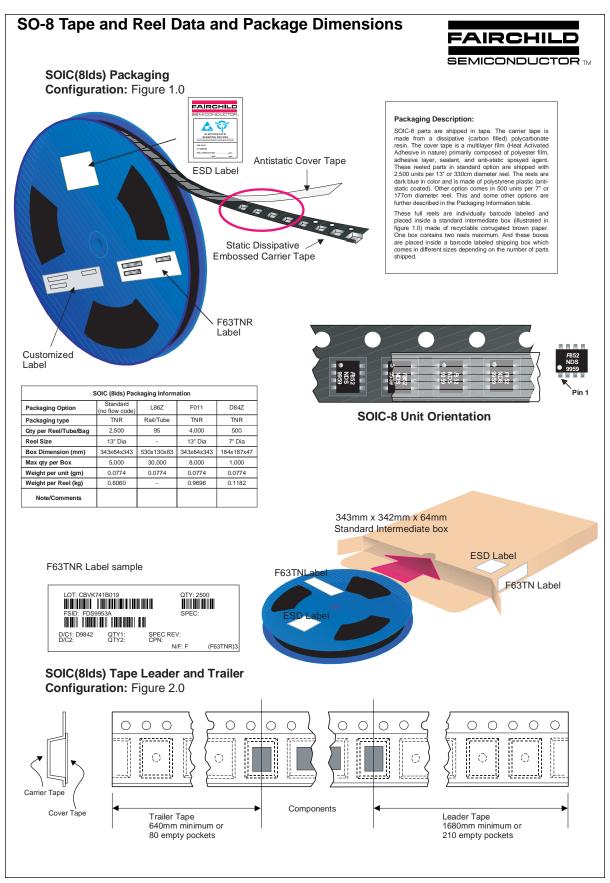


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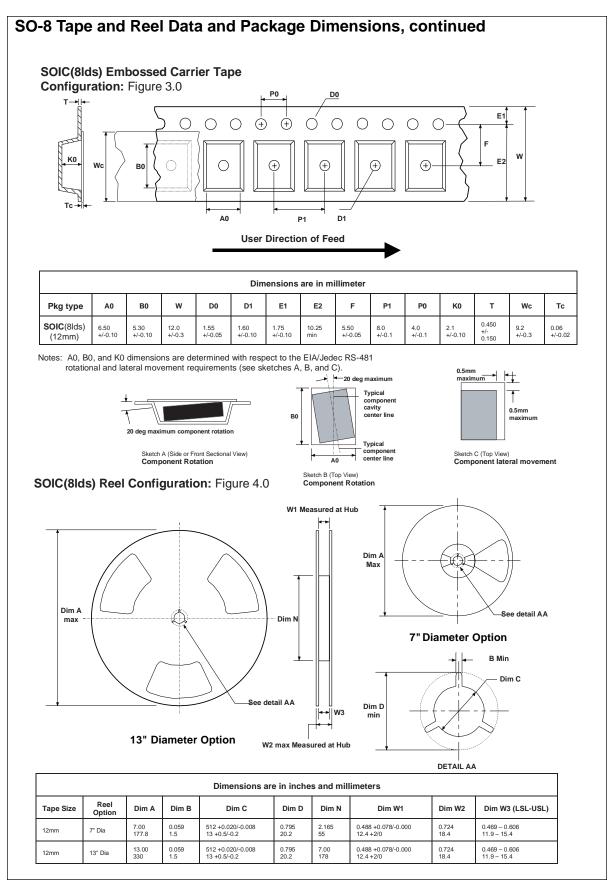


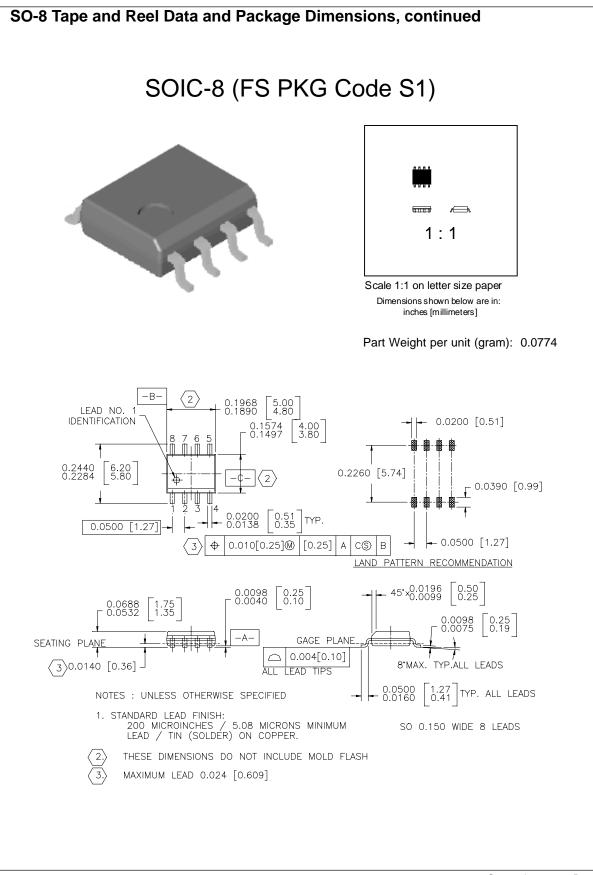


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July 1999, Rev. B





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